TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( $\pi$ -MOSVI)

# 2SK3869

### **Switching Regulator Applications**

- Low drain-source ON resistance: RDS (ON) = 0.55  $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 5.5 \text{ S (typ.)}$
- Low leakage current: IDSS = 100  $\,\mu$  A (VDS = 450 V)
- Enhancement model:  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

## **Maximum Ratings (Ta = 25°C)**

Characteristic		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	450	V	
Drain-gate voltage (I	$R_{GS} = 20 \text{ k}\Omega$	V <sub>DGR</sub>	450	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	10	А	
	Pulse (t = 1 ms) (Note 1)	I <sub>DP</sub>	40		
Drain power dissipat	ion (Tc = 25°C)	PD	40	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	222	mJ	
Avalanche current		I <sub>AR</sub>	10	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	4	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	-55~150	°C	

# Unit: mm \$\int\_{0.69\pmodelse}^{0.200}\text{A}\$ 1.14\pmodelse\_{0.200}^{10\pmodelse\_{0.69\pmodelse\_{0.70}}^{10\pmodelse\_{0.69\pmodelse\_{0.70}}^{10\pmodelse\_{0.69\pmodelse\_{0.70}}^{10\pmodelse\_{0.69\pmodelse\_{0.70}}^{10\pmodelse\_{0.70}^{10\pmodelse\_{0.70}}^{10\pmodelse\_{0.70}^{10\pmode

Weight: 1.7 g (typ.)

### **Thermal Characteristics**

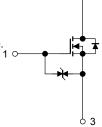
Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	3.125	°C/W	
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	62.5	°C/W	

Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.

Note 2:  $V_{DD} = 90 \text{ V}$ ,  $T_{ch} = 25^{\circ}\text{C}$  (initial), L = 3.7 mH,  $I_{AR} = 10 \text{ A}$ ,  $R_G = 25 \Omega$ 

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



**Ω** 2



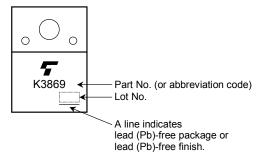
# **Electrical Characteristics (Ta = 25°C)**

Char	acteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Gate-source brea	akdown voltage	V (BR) GSS	$I_G=\pm 10~\mu A,~V_{GS}=0~V$	±30	_	_	V
Drain cutoff curre	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 450 V, V <sub>GS</sub> = 0 V		_	100	μΑ
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	450	_	_	V
Gate threshold vo	oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source ON	resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A		0.55	0.68	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5 A	2.5	5.5	_	S
Input capacitance		C <sub>iss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1050	_	pF
Reverse transfer capacitance		C <sub>rss</sub>			10	_	
Output capacitance		Coss		_	110	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS}$ $V_{OS}$	_	25	_	ns
	Turn-on time	t <sub>on</sub>		_	60	_	
	Fall time	t <sub>f</sub>		_	40	_	
	Turn-off time	t <sub>off</sub>	Duty $\leq$ 1%, $t_W = 10 \mu s$	_	130	_	
Total gate charge		Qg		_	28	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \simeq 360 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	_	16	_	nC
Gate-drain charge		Q <sub>gd</sub>			12	_	

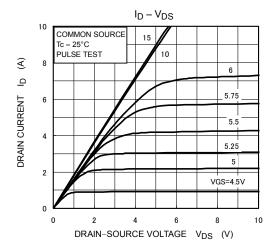
# Source-Drain Ratings and Characteristics (Ta = 25°C)

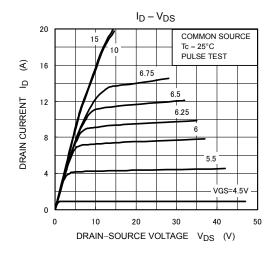
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	40	Α
Forward voltage (diode)	V <sub>DSF</sub>	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	$I_{DR} = 10 \text{ A}, V_{GS} = 0 \text{ V},$	_	1000	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 100 A/μs	_	8.8	_	μС

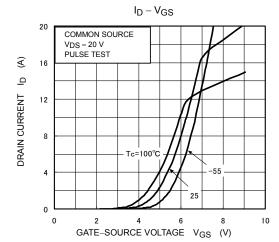
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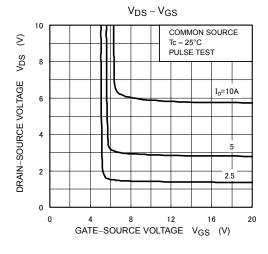


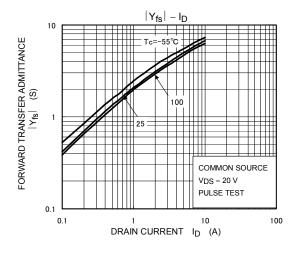
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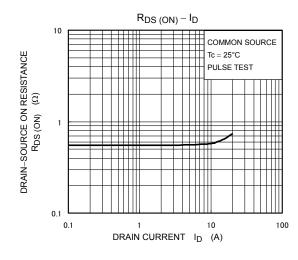


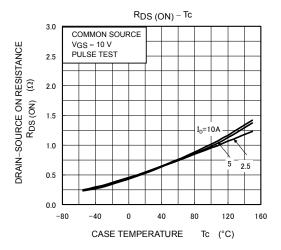


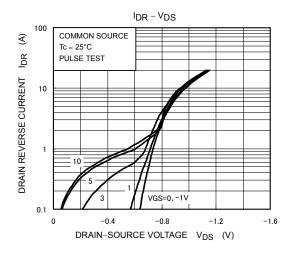


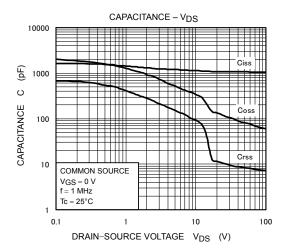


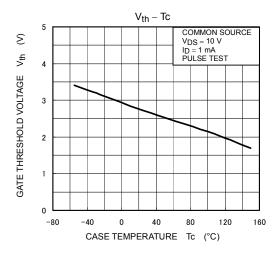


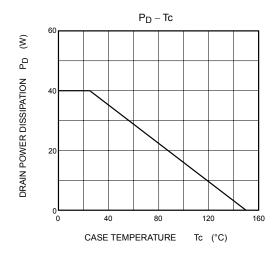


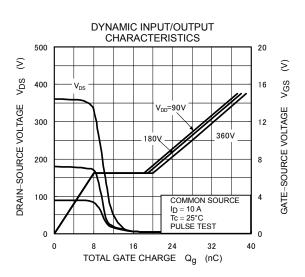




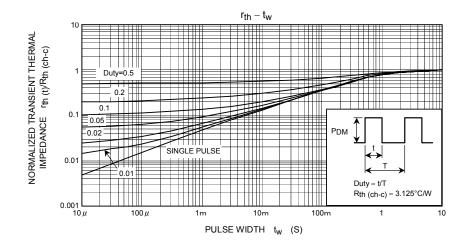


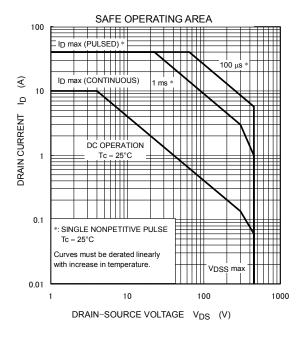


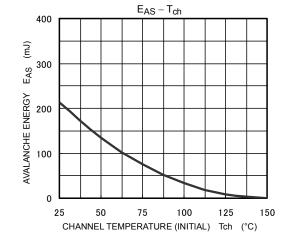


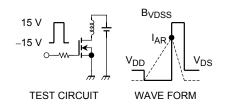


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$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 3.7~mH \end{aligned}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right)$$

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